

A Set of Grisms for FORS

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1. Introduction

The University Observatories of München and Göttingen and the Landessternwarte Heidelberg are building in cooperation with ESO two almost identical **F**Ocal **R**educer /low-dispersion **S**pectrographs (FORS) for the ESO Very Large Telescopes. FORS allows low-dispersion multiobject spectroscopy (19 slits) and longslit spectroscopy in the wavelength range of 330 to 1100 nm. A set of standard grisms with reciprocal dispersions of 45 ... 230 Å/mm working in the first order are foreseen. With a slitwidth of 1 arcsec the resulting spectral resolutions range from 180 to 1800.

For further FORS details see Appenzeller and Rupprecht (1992) and Seifert et al. (1994).

2. The FORS Standard Grisms

The standard grisms are located in a grism wheel in the parallel beam between the collimator and the camera. Seven of eight positions are available for grisms. The free diameter of the grisms is 135 mm to cover the whole field of view of FORS. To avoid reflection ghosts the entrance surfaces are all tilted by 7°5.

Table 1. FORS standard and cross-disperser grisms.

| no. | | mechanical parameters | | | | | spectral parameters | | | |
|-------|------|-----------------------|--------------------|-------|-----------|--------|----------------------|----------|---------|--|
| cross | std. | glass | n_{glass} | gr/mm | φ | ψ | $\Delta\lambda$ [nm] | d [Å/mm] | R (1'') | |
| I | 1 | FK 5 | 1.49 | 600 | 34° | 28° | 350 ... 590 | 50 | 815 | |
| II | | F 2 | 1.62 | 600 | 34° | 34° | 460 ... 710 | 49 | 1030 | |
| | 2 | K 5 | 1.524 | 600 | 46° | 49° | 525 ... 740 | 45 | 1230 | |
| | 3 | SF 5 | 1.68 | 600 | 46° | 49° | 690 ... 910 | 44 | 1530 | |
| | 4 | SF 11 | 1.79 | 600 | 46° | 49° | 800 ... 1030 | 45 | 1760 | |
| III | 5 | FK 5 | 1.49 | 300 | 21° | 17°5 | 330 ... (650) | 110 | 420 | |
| | 5 | +GG435 | | | | | (450) ... 860 | 112 | 500 | |
| | 6 | LF 5 | 1.58 | 300 | 26°7 | 26°7 | 600 ... 1140 | 108 | 680 | |
| | 7 | BaK 2 | 1.54 | 150 | 11°5 | 8°6 | 330 ... (650) | 225 | 185 | |
| | 7 | +OG590 | | | | | (590) ... 1100 | 230 | 280 | |

φ prism angle, ψ groove angle, d reciprocal dispersion,
 R spectral resolution for 1'' slit width, $\Delta\lambda$ wavelength range (1. order).

Due to the space restrictions in the parallel beam the maximum length of the grisms is 115 mm corresponding to a prism angle of 46°. Table 1 contains the mechanical and spectroscopic parameters of the selected standard grisms.

The spectral dispersion curves of the gratings cover the whole spectral range of the FORS instrument with three different resolutions. The dimensions of the ruled areas required are quite large (e.g. 120×153 mm for the 46° gratings) and therefore only a few suitable standard master gratings exist. Nevertheless, all standard gratings can be realized using already existing master gratings. The material for the gratings were selected with respect to the transmission and the refractive index of the corresponding glasses.

The standard gratings are normally used in the first order. For wavelengths longer than 660 nm filters to separate the second order are needed. According to Table 1 the gratings nos. 5 and 7 can be used with and without an order separation filter in separate wavelength ranges. In both cases the surface of the CCD chip is (in one dimension) only partially utilized.

3. Gratings for an Echelle Mode

For the second copy of FORS the polarimetric observing mode will be replaced by an echelle spectroscopy mode. The cross-disperser gratings will be located in the “Wollaston wheel” in front of the pupil stop and the echelle gratings in the grating wheel. For three overlapping wavelength ranges a set of two echelle gratings (Table 2) and three cross-disperser gratings (also in Table 1) are planned. The echelle gratings are used in the orders 3 to 16. The maximum grating angle is about 51°.

Table 2. FORS echelle gratings.

| no. | wavelength range [nm] | glass | n_{glass} | n_{resin} | grooves /mm | φ | ψ | orders | R (1") |
|-----|-----------------------|-------|--------------------|--------------------|-------------|-----------|--------|--------|-------------|
| I | 340...590 | BaK 2 | 1.54 | 1.525 | 225.75 | 51°4 | 54° | 3... 6 | 1500...1825 |
| II | 460...710 | SF 57 | 1.84 | 1.665 | 98.76 | 51°2 | 63°5 | 8...16 | 2280...3000 |
| III | 600...1100 | SF 57 | 1.84 | 1.665 | 98.76 | 51°2 | 63°5 | 6...11 | 2200...2470 |

For the wavelength ranges II and III the same echelle grating can be used.

The minimum local order separation is better than 230 pixels (5.6 mm). Hence, a “longslit” of up to two slitlets can be used in this mode.

In addition, three advanced echelle gratings with gratings of more exotic materials with higher refractive indices (sapphire, zinc sulfide) are being studied. It seems to be possible to increase the spectral resolution (1" slit) up to 2300 in the wavelength range I (340...590 nm) and up to 4000 in the other ranges. At the present time the realization of these gratings is not yet certain.

References

- Appenzeller, I. and Rupprecht, G. 1992, *The Messenger*, **67**, 18
 Seifert, W., Mitsch, W., Nicklas, H. and Rupprecht, G. 1994, in *Proc. SPIE* **2198**, D. L. Crawford and E. R. Craine (eds.), 1994, in press